



Description

The STD2LN60K3 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge. This device is suitable for use as a Battery protection or in other Switching application.

General Features

$V_{DS} = 600V$ $I_D = 2A$

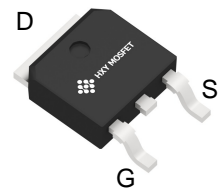
$R_{DS(ON)} < 4.5\Omega$ @ $V_{GS}=10V$

Application

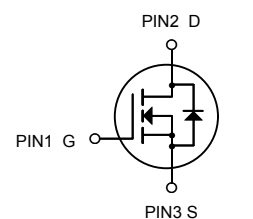
Battery protection

Load switch

Uninterruptible power supply



TO-252-2L
(TO-252(DPAK))



N-Channel MOSFET

Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
STD2LN60K3	TO-252-2L(TO-252(DPAK))	HXY MOSFET	2500

Absolute Maximum Ratings $T_C=25^{\circ}C$ unless otherwise noted

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	600	V
V_{GS}	Gate-Source Voltage	± 30	V
$I_D@T_C=25^{\circ}C$	Continuous Drain Current, V_{GS} @ 10V ^[1]	2	A
$I_D@T_C=100^{\circ}C$	Continuous Drain Current, V_{GS} @ 10V ^[1]	1.2	A
I_{DM}	Pulsed Drain Current ^[2]	8	A
$P_D@T_C=25^{\circ}C$	Total Power Dissipation ^[1]	31	W
T_{STG}	Storage Temperature Range	-55 to 150	$^{\circ}C$
T_J	Operating Junction Temperature Range	-55 to 150	$^{\circ}C$
$R_{\theta JA}$	Thermal Resistance Junction-ambient ^[6]	100	$^{\circ}C/W$
$R_{\theta JC}$	Thermal Resistance Junction-Case ^[1]	4.0	$^{\circ}C/W$



Electrical Characteristics ($T_J=25^{\circ}\text{C}$, unless otherwise noted)

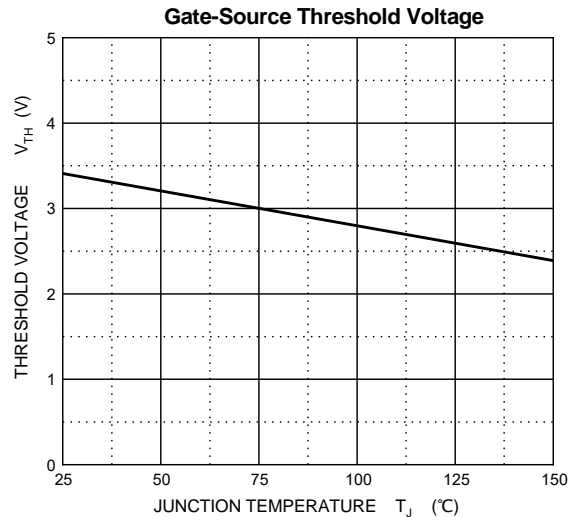
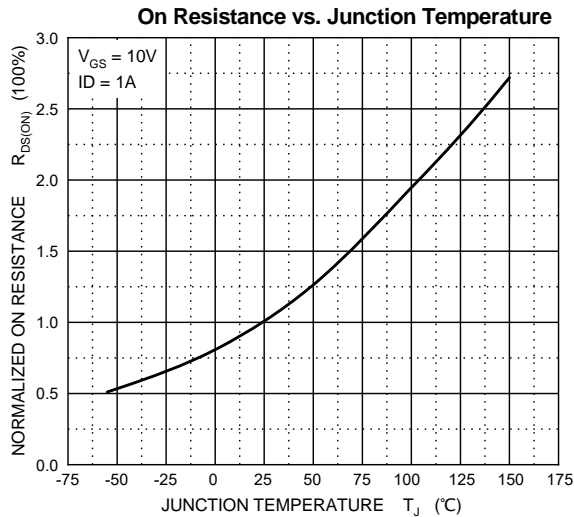
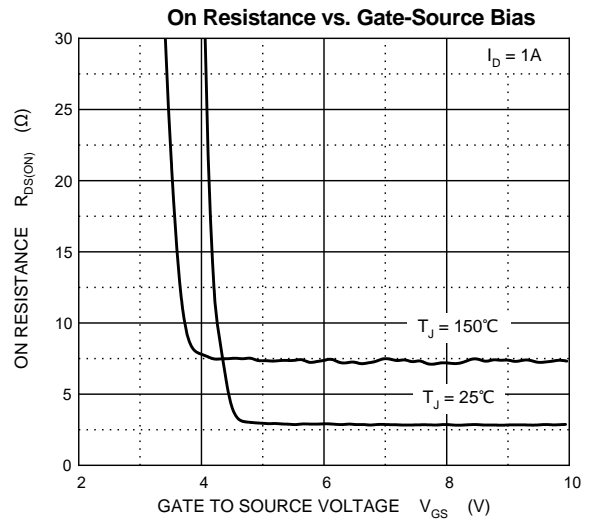
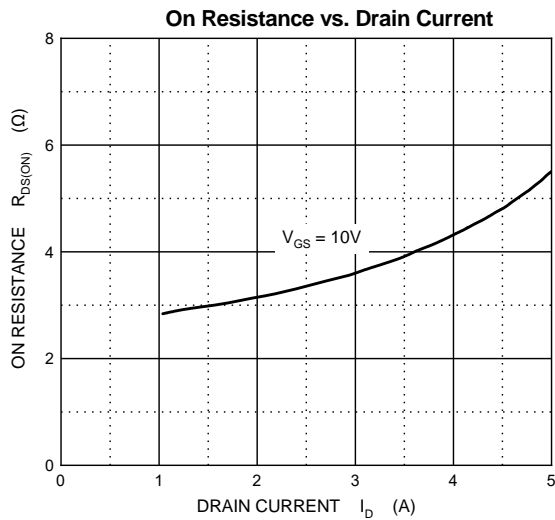
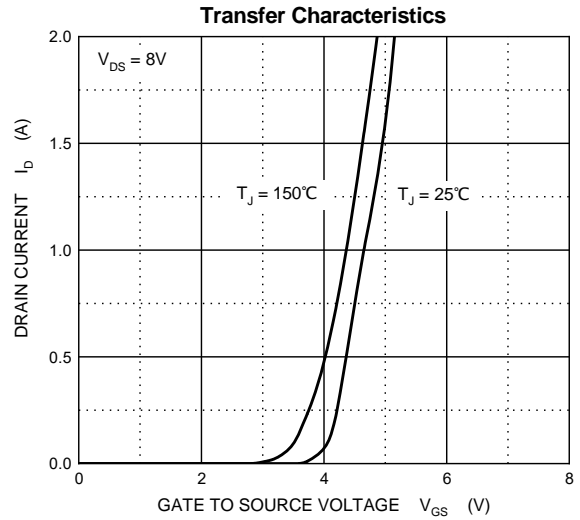
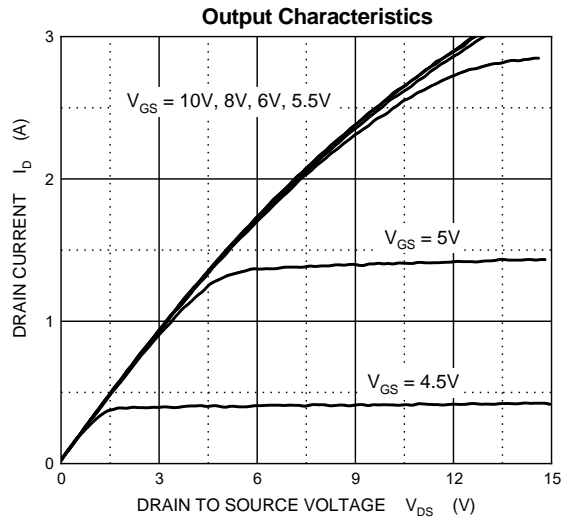
Parameter	Symbol	Test Condition	Min	Typ	Max	Unit
Off characteristics						
Drain-source breakdown voltage	$V_{(BR)DSS}$	$V_{GS}=0V, I_D=250\mu A$	600			V
Zero gate voltage drain current	I_{DSS}	$V_{DS}=600V, V_{GS}=0V$			1.0	μA
Gate-body leakage current	I_{GSS}	$V_{DS}=0V, V_{GS}=\pm 30V$			± 100	nA
On characteristics ^[4]						
Gate-threshold voltage	$V_{GS(th)}$	$V_{DS}=V_{GS}, I_D=250\mu A$	2.0	3.4	4.0	V
Static drain-source on-sate resistance	$R_{DS(on)}$	$V_{GS}=10V, I_D=1A$		3.7	4.5	Ω
Dynamic characteristics ^[5]						
Input capacitance	C_{iss}	$V_{DS}=25V, V_{GS}=0V,$ $f=1MHz$		322		pF
Output capacitance	C_{oss}			38		
Reverse transfer capacitance	C_{rss}			7		
Gate resistance	R_g	$f=1MHz$		5.7		Ω
Switching characteristics ^[5]						
Total gate charge	Q_g	$V_{GS}=10V,$ $V_{DS}=25V, I_D=2A$		1.6		nC
Gate-source charge	Q_{gs}			2.1		
Gate-drain charge	Q_{gd}			6.2		
Turn-on delay time	$t_{d(on)}$	$V_{DD}=25V, V_{GS}=10V,$ $R_G=18\Omega, I_D=2A$		1.8		nS
Turn-on rise time	t_r			3.2		
Turn-off delay time	$t_{d(off)}$			7.4		
Turn-off fall time	t_f			7.6		
Drain-Source Diode Characteristics						
Drain-source diode forward voltage ^[4]	V_{SD}	$V_{GS}=0V, I_S=2A$			1.4	V
Continuous drain-source diode forward current ^[1]	I_S				2.0	A
Pulsed drain-source diode forward current ^[2]	I_{SM}				8.0	A
Reverse recovery time	t_{rr}	$dIF/dt=100A/\mu s,$ $I_S=2A, V_{DD}=400V$		192		ns
Reverse recovery charge	Q_{rr}			1027		nC

Notes:

1. $T_C=25^{\circ}\text{C}$ Limited only by maximum temperature allowed.
2. $P_W \leq 10\mu s$, Duty cycle $\leq 1\%$.
3. EAS condition: $V_{DD}=150V, V_{GS}=10V, L=10mH, R_g=25\Omega$ Starting $T_J = 25^{\circ}\text{C}$.
4. Pulse Test : Pulse Width $\leq 300\mu s$, duty cycle $\leq 2\%$.
5. Guaranteed by design, not subject to production.
6. The value of $R_{\theta JA}$ is measured with the device in a still air environment with $T_A=25^{\circ}\text{C}$.

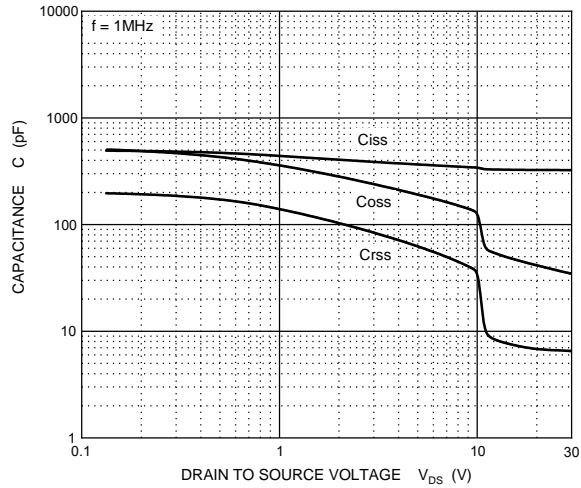


Typical Characteristics

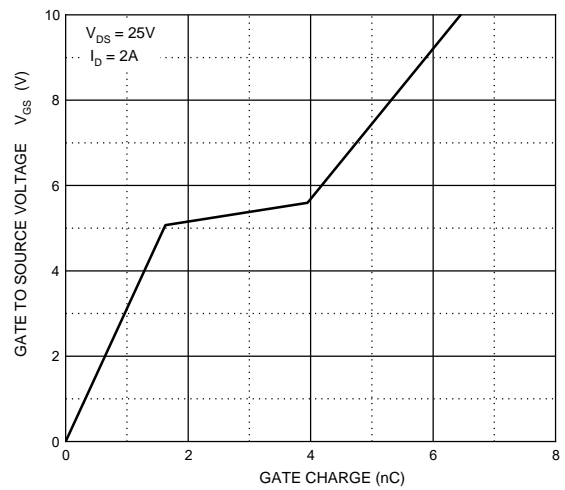




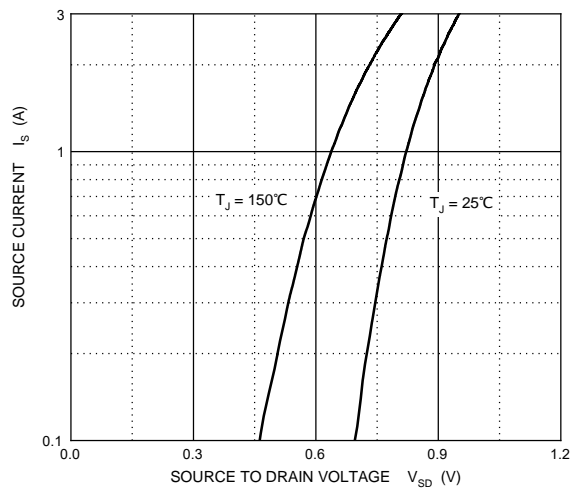
Typical Capacitances



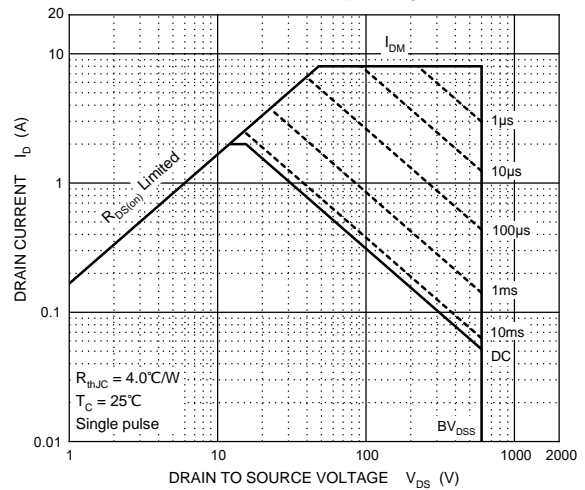
Gate Charge



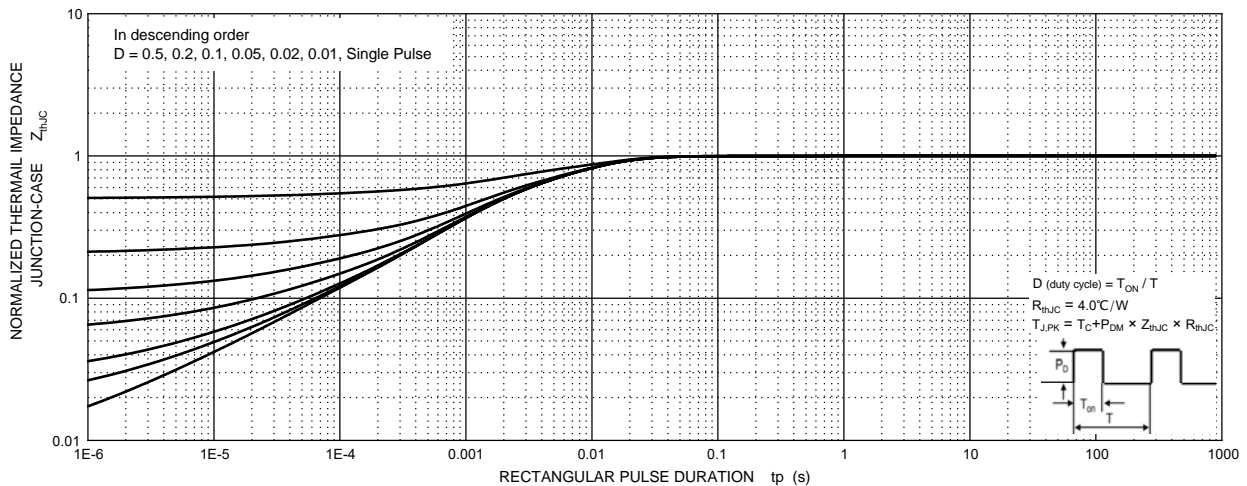
Source-Drain Diode Forward Characteristics

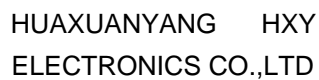


Maximum Safe Operating Area



Transient Thermal Impedance, Junction-Case





N-Channel Enhancement Mode MOSFET

Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	2.200	2.400	0.087	0.094
A1	0.000	0.127	0.000	0.005
b	0.660	0.860	0.026	0.034
c	0.460	0.580	0.018	0.023
D	6.500	6.700	0.256	0.264
D1	5.100	5.460	0.201	0.215
D2	0.483 TYP.		0.190 TYP.	
E	6.000	6.200	0.236	0.244
e	2.186	2.386	0.086	0.094
L	9.800	10.400	0.386	0.409
L1	2.900 TYP.		0.114 TYP.	
L2	1.400	1.700	0.055	0.067
L3	1.600 TYP.		0.063 TYP.	
L4	0.600	1.000	0.024	0.039
Φ	1.100	1.300	0.043	0.051
θ	0°	8°	0°	8°
h	0.000	0.300	0.000	0.012
V	5.350 TYP.		0.211 TYP.	



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